

**AMENDMENTS TO THE CLAIMS:**

Please amend claims 8-11 and add new claims 28-30 as shown below. This listing of claims will replace all prior versions and listings of claims in the Application:

**Claims 1-7 (canceled)**

**Claim 8 (currently amended):** A method for forming an optical element comprising the steps of:

forming on a substrate a multilayer film ~~composed~~ consisting of a stack of alternating layers of high refractive index material and low refractive index material to control a phase and an amplitude of emerging rays; and

adjusting a wavefront phase of the emerging rays by cutting away a portion of the multilayer film stack in accordance with an amount of adjustment of the wavefront phase.

**Claim 9 (currently amended):** A method according to claim 8, wherein the multilayer film stack is formed in a number of cycles larger than that necessary to saturate a reflectance.

**Claim 10 (currently amended):** A method according to claim 8, wherein cutting-away of the multilayer film is controlled by detecting a difference ~~between~~ in a material that forms the multilayer film stack.

**Claim 11 (currently amended):** A method for forming an optical element, comprising the steps of:

forming on a substrate a multilayer film ~~composed~~ consisting of a stack of alternating layers of high refractive index material and low refractive index material in a number of cycles larger than that necessary to saturate a reflectance;

forming a correction film on the multilayer film; and

cutting away a portion of the correction film ~~or the correction film~~ and the multilayer film stack in accordance with an amount of adjustment of a wavefront phase of emerging rays.

**Claims 12-27 (canceled)**

**Claim 28 (new):** A method according to claim 10, wherein a difference in material is detected by monitoring a secondary electronic discharge.

**Claim 29 (new):** A method according to claim 10, wherein a difference in material is detected by monitoring an optional change of characteristics.

**Claim 30 (new):** A method according to claim 29, wherein said optical change of characteristics monitored is a change in an optical constant of visible rays or a change ellipsometry.

**HAYES SOLOWAY P.C.**  
130 W. CUSHING STREET  
TUCSON, AZ 85701  
TEL. 520.882.7623  
FAX. 520.882.7643

175 CANAL STREET  
MANCHESTER, NH 03101  
TEL. 603.668.1400  
FAX. 603.668.8567